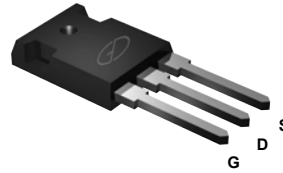
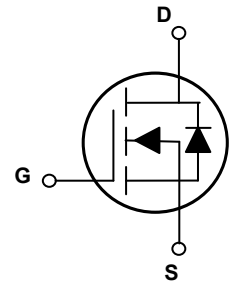


### Main Product Characteristics

$V_{(BR)DSS}$	600V
$R_{DS(ON)}$	69mΩ (max.)
$I_D$	48A



TO-247



Schematic Diagram

### Features and Benefits

- Advance MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



### Description

The GSJA60R069 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supplies and a wide variety of other applications.

### Absolute Maximum Ratings ( $T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Max.	Unit
Drain-Source Voltage	$V_{DS}$	600	V
Gate-Source Voltage	$V_{GS}$	±30	V
Drain Current-Continuous, at Steady-State, ( $T_C=25^\circ\text{C}$ )	$I_D$	48	A
Drain Current-Continuous, at Steady-State, ( $T_C=100^\circ\text{C}$ )		30	
Drain Current-Pulsed	$I_{DM}$	192	A
Single Pulse Avalanche Energy <sup>1</sup>	$E_{AS}$	2650	mJ
Single Pulse Current	$I_{AS}$	12.4	A
Power Dissipation ( $T_C=25^\circ\text{C}$ )	$P_D$	415	W
		3.32	W/°C
Body Diode Reverse Voltage Slope <sup>2</sup>	$dv/dt$	15	V/ns
MOS $dv/dt$ Ruggedness <sup>3</sup>	$dv/dt$	50	V/ns
Junction-to-Ambient (PCB Mounted, Steady-State)	$R_{\theta JA}$	50	°C/W
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	0.30	°C/W
Operating Junction Temperature Range	$T_J$	-55 To +150	°C
Storage Temperature Range	$T_{STG}$	-55 To +150	°C
Soldering Temperature	$T_{sold}$	260	°C

### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>On / Off Characteristics</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	600	-	-	V
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =600V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	-	-	1.0	μA
		V <sub>DS</sub> =600V, V <sub>GS</sub> =0V, T <sub>J</sub> =125°C	-	2.0	-	μA
Gate-Source Forward Current	I <sub>GSS</sub>	V <sub>GS</sub> =±30V, V <sub>DS</sub> =0V	-	-	±100	nA
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =23A	-	54	69	mΩ
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	2.0	-	4.0	V
<b>Dynamic and Switching Characteristics</b>						
Total Gate Charge <sup>4,5</sup>	Q <sub>g</sub>	V <sub>DD</sub> =480V, I <sub>D</sub> =47A, V <sub>GS</sub> =10V	-	96	-	nC
Gate-Source Charge <sup>4,5</sup>	Q <sub>gs</sub>		-	22	-	
Gate-Drain ("Miller") Charge <sup>4,5</sup>	Q <sub>gd</sub>		-	48	-	
Gate to Plateau <sup>4,5</sup>	V <sub>plateau</sub>		-	6.3	-	V
Turn-On Delay Time <sup>4,5</sup>	t <sub>d(on)</sub>	V <sub>DD</sub> =380V, R <sub>G</sub> =1.8Ω, V <sub>GS</sub> =10V, I <sub>D</sub> =47A	-	23	-	nS
Rise Time <sup>4,5</sup>	t <sub>r</sub>		-	32	-	
Turn-Off Delay Time <sup>4,5</sup>	t <sub>d(off)</sub>		-	86	-	
Fall Time <sup>4,5</sup>	t <sub>f</sub>		-	24	-	
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V, F=1MHz	-	3082	-	pF
Output Capacitance	C <sub>oss</sub>		-	171	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	9.4	-	
Gate Resistance	R <sub>g</sub>	F=1MHz	-	2.1	-	Ω
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
Continuous Source Current (Body Diode)	I <sub>S</sub>	T <sub>C</sub> =25°C, MOSFET symbol showing the integral reverse p-n junction diode.	-	-	48	A
Pulsed Source Current	I <sub>S,PULSE</sub>		-	-	192	A
Diode Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =47A	-	-	1.4	V
Reverse Recovery Time <sup>4</sup>	t <sub>rr</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =47A, dI <sub>F</sub> /dt=100A/μs	-	586	-	nS
Reverse Recovery Charge <sup>4</sup>	Q <sub>rr</sub>		-	14	-	μC
Reverse Recovery Peak Current <sup>4</sup>	I <sub>rrm</sub>		-	44	-	A

Note:

- L=30mH, V<sub>DD</sub>=100V, R<sub>G</sub>=25Ω, starting temperature T<sub>J</sub>=25°C.
- V<sub>DS</sub>= 0 - 400V, I<sub>SD</sub> ≤ I<sub>S</sub>, T<sub>J</sub>=25°C.
- V<sub>DS</sub>= 0 - 480V.
- Pulse test: pulse width ≤ 300us, duty cycle ≤ 2%.
- Essentially independent of operating temperature.

### Typical Electrical and Thermal Characteristic Curves

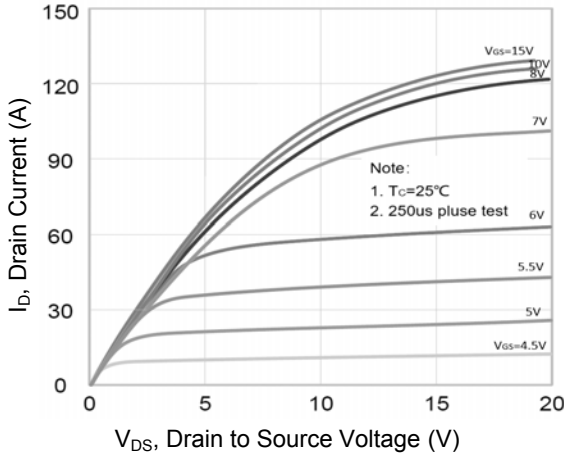


Figure 1. Typical Output Characteristics

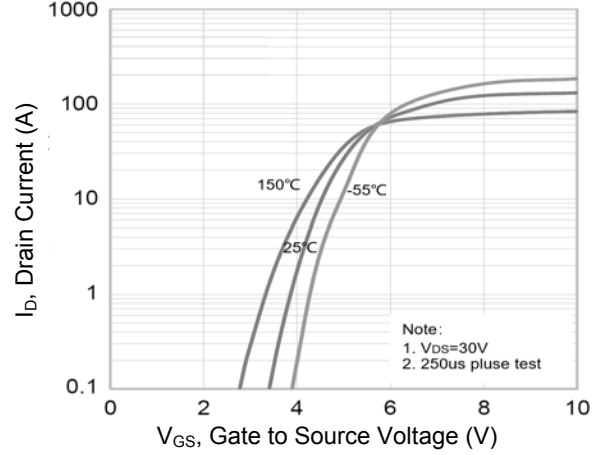


Figure 2. Transfer Characteristics

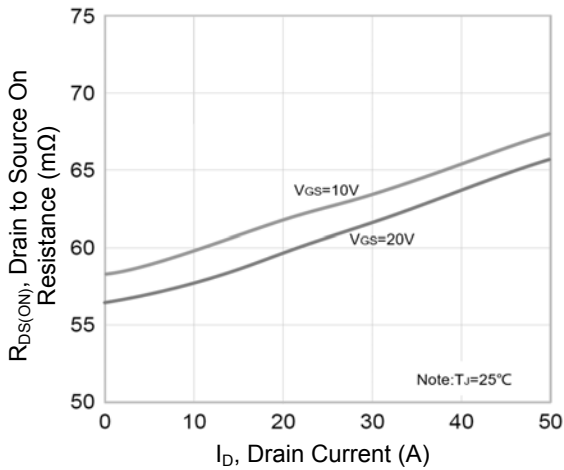


Figure 3.  $R_{DS(ON)}$  vs. Drain Current

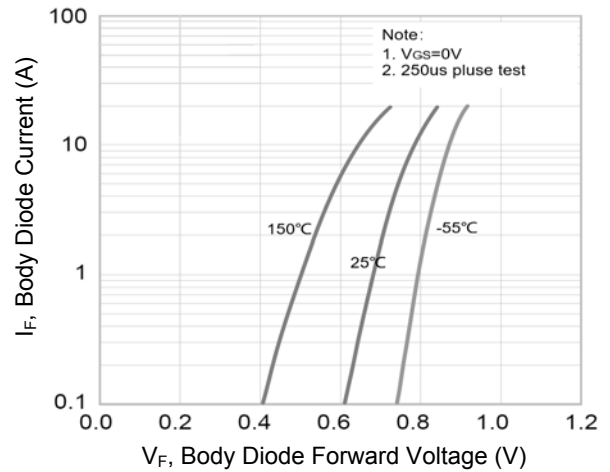


Figure 4. Body Diode Characteristics

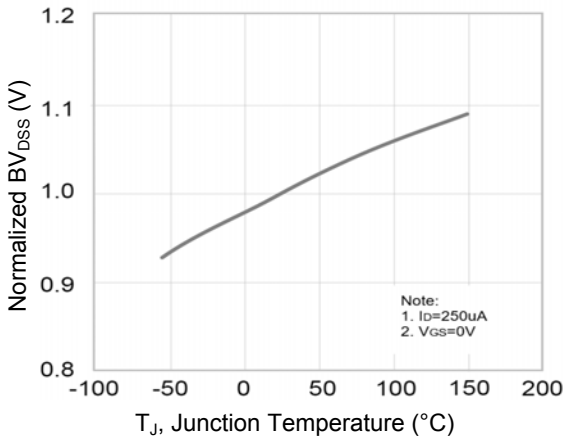


Figure 5. Normalized  $BV_{DSS}$  vs.  $T_J$

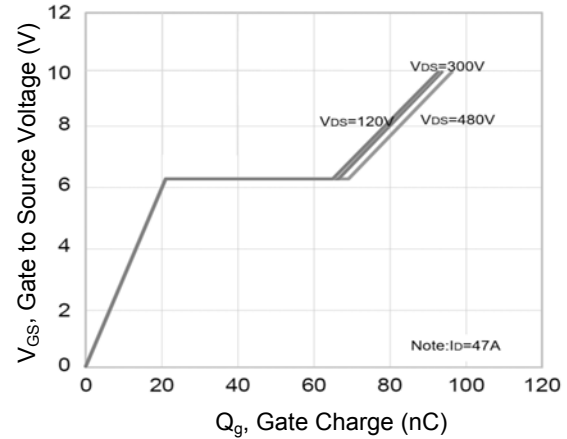
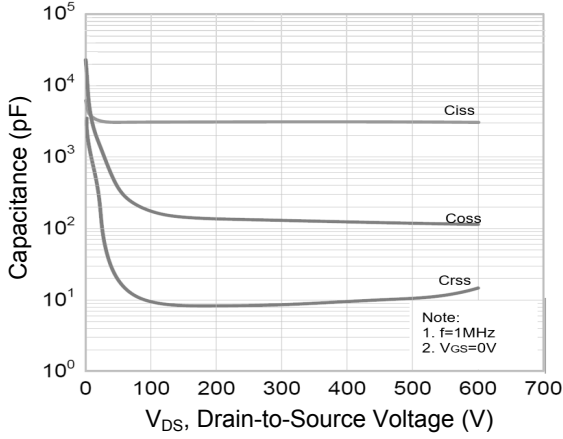
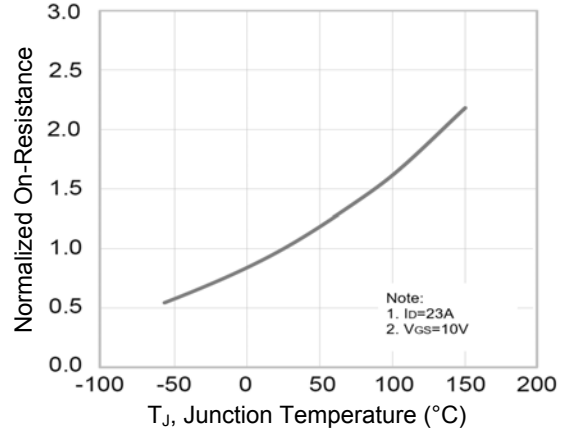


Figure 6. Gate Charge Characteristics

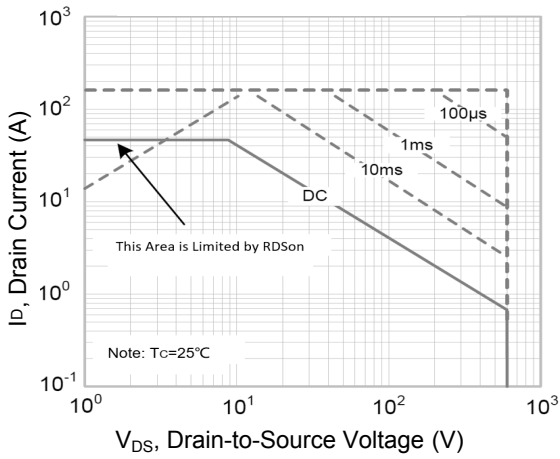
**Typical Electrical and Thermal Characteristic Curves**



**Figure 7. Capacitance Characteristics**

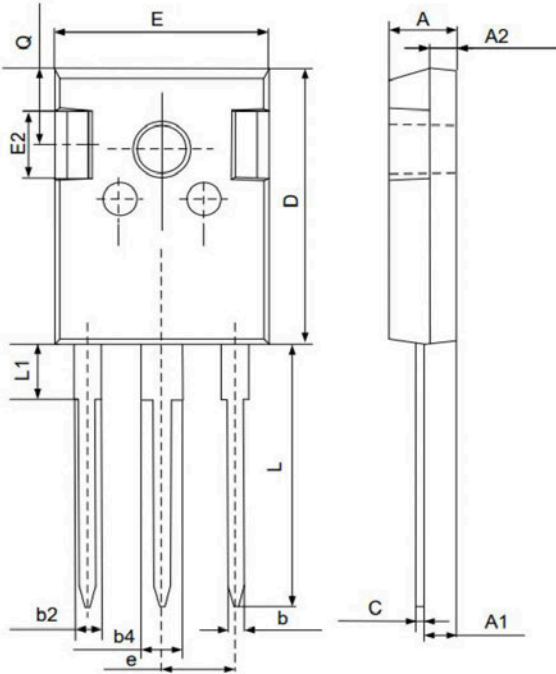


**Figure 8. Normalized R<sub>DS(ON)</sub> vs. T<sub>J</sub>**



**Figure 9. Safe Operation Area**

## Package Outline Dimensions (TO-247)



Symbol	Dimensions in Millimeters		Dimensions in Inches	
	Min	Max	Min	Max
A	4.800	5.200	0.189	0.205
A1	2.210	2.590	0.087	0.102
A2	1.850	2.150	0.073	0.085
b	1.110	1.360	0.044	0.054
b2	1.910	2.250	0.075	0.089
b4	2.910	3.250	0.115	0.128
c	0.510	0.750	0.020	0.030
D	20.800	21.300	0.819	0.839
E	15.500	16.100	0.610	0.634
E2	4.400	5.200	0.173	0.205
e	5.440 BSC		0.214 BSC	
L	19.720	20.220	0.776	0.796
L1	-	4.300	-	0.169
Q	5.600	6.000	0.220	0.236